

**2006**

# **International Technology Roadmap for Semiconductors**

## **Radio Frequency and Analog/Mixed-Signal Technologies for Wireless Communications Working Group**

**ITRS Public Conference  
Dec 5 2006  
Hsin Chu, Taiwan**

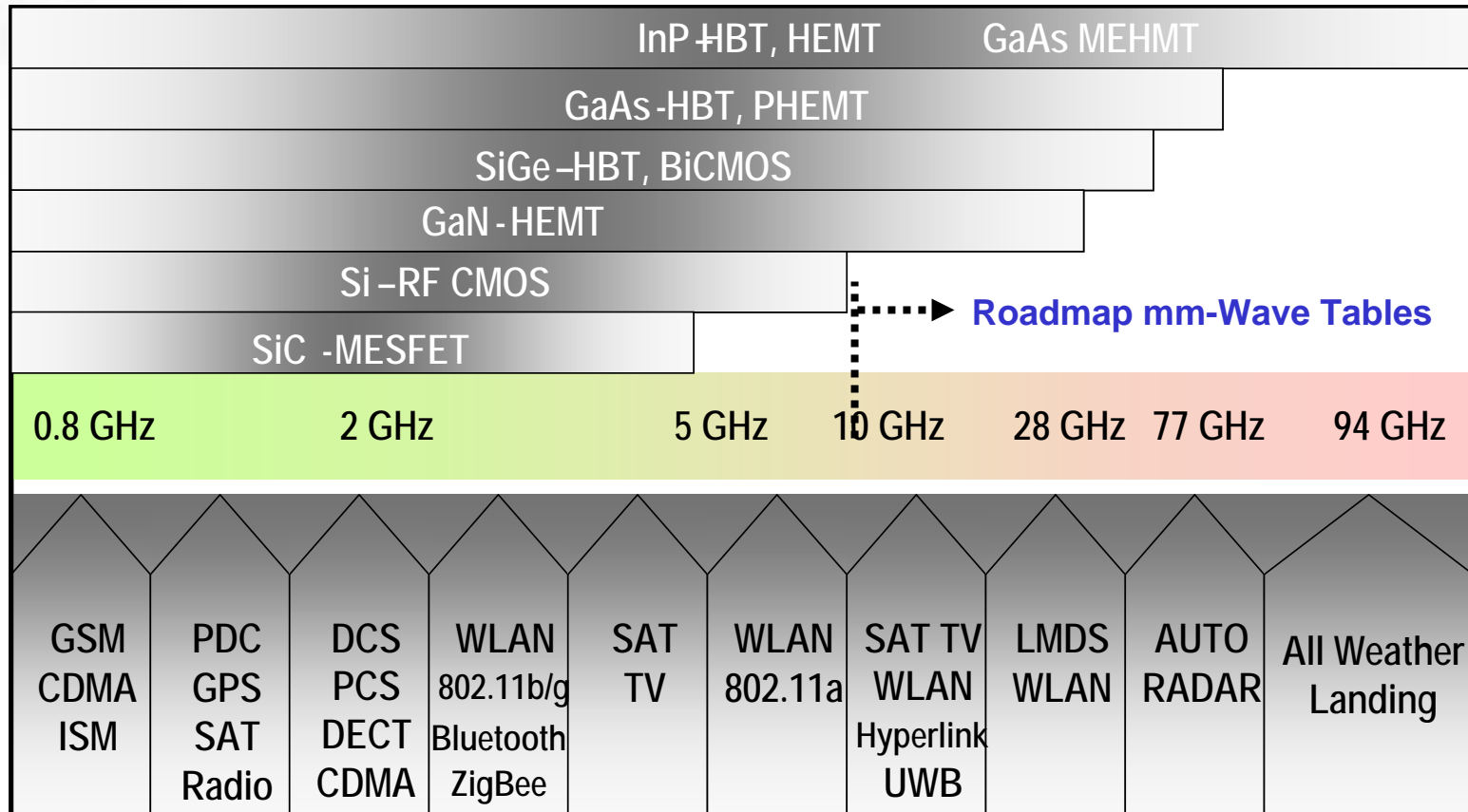


# Wireless ITWG Scope

- Use wireless IC as technology driver
- Roadmap technical requirements, challenges and potential solutions for RF and AMS IC technologies in wireless applications such as cellular phones, WLAN, WPAN, automotive radar, phased array systems and other emerging standards
- Address intersection of silicon with III-V compound semiconductors and other potential technologies (MEMS, BAW, ..)



# Wireless Communication Application Spectrum

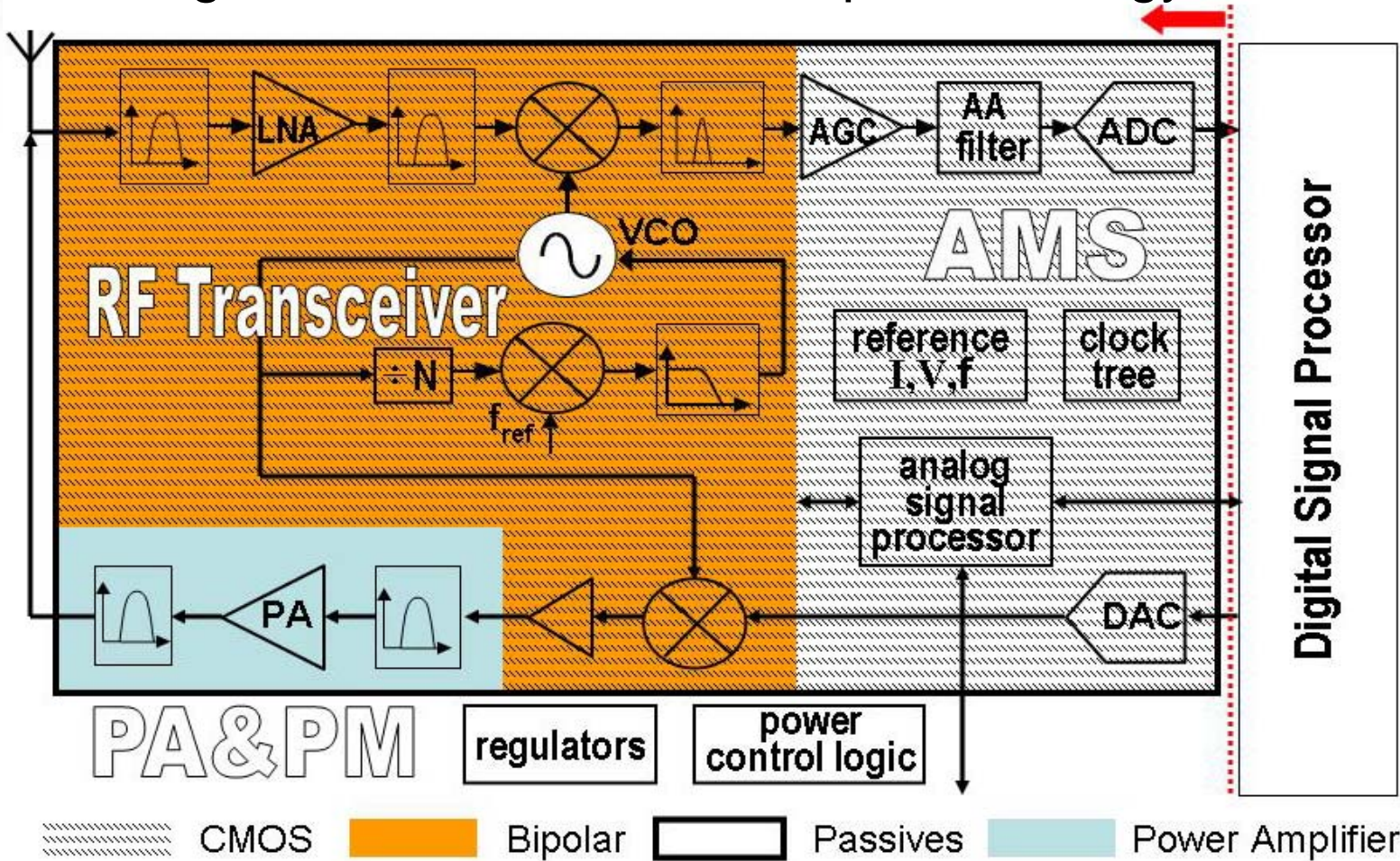


Applications drive Noise Figure, Power, Power Added Efficiency, Linearity and Cost



# Circuit Functions of a Typical Wireless Communication System

Showing ITRS Wireless Roadmap Technology Partition



# Wireless ITWG Methodology

## Communication System

- Protocols/Standards
- Frequencies 0.8 – 100GHz
- Architecture

## Circuit Figures-of-Merit

- Dynamic Range, Bandwidth
- Gain, Noise Figure, Linearity
- Phase Noise
- Output Power, Gain, PAE
- Power Consumption

## Device Figures-of-Merit

- Mismatch, Gain
- $f_T$  &  $f_{MAX}$
- NFmin & 1/f noise
- Breakdown
- Quality factor, linearity
- Power density, PAE
- COST

# 2006 Wireless ITWG Organization

Chair:	W. Margaret Huang	Freescale
Co-Chairs:	Bin Zhao	Skyworks
	Jan-Erik Mueller	Infineon

Herbert Bennett	NIST
Doug Coolbaugh	IBM
Julio Costa	RFMD
Peter Cottrell	IBM
Stefaan Decoutere	IMEC
Erwin Hijzen	Philips
Digh Hisamoto	Hitachi
Anthony Immorlica	BAE Systems
<b>Snezana Jenei</b>	<b>Infineon</b>
Jay John	Freescale
Alvin Joseph	IBM
Takahiro Kamei	Oki
Tom Kazior	Raytheon

Yukihiro Kiyota	Sony
Minh Le	Consultant
<b>Sebastian Liau</b>	<b>ITRI Taiwan</b>
<b>Hansu Oh</b>	<b>Samsung</b>
Marco Racanelli	Jazz
Bernard Sautreuil	ST Micro
Sam Shichijo	TI
Chuck Weitzel	Freescale
Geoffrey Yeap	Qualcomm
Peter Zampardi	Skyworks
Herbert Zirath	Chalmers U
John Zolper	DARPA



# 2006 Organization

**Chair :** Margaret Huang, Freescale

**27 Members /last year 34**

**Co-chairs :** Bin Zhao, Skyworks

**16 US, 6 Europe, 5 AP**

Jan-Erik Mueller, Infineon

**Editor :** Herbert Bennett, NIST

• **Subgroup (1) : CMOS (11)**

**Peter Cotrell, IBM**

• **Subgroup (2) : Bipolar (6)**

**Marco Racanelli, Jazz**

• **Subgroup (3) : Passives (5)**

**Sam Shichijo, TI**

• **Subgroup (4) : PA & power management (4)**

**P. Zampardi, Skyworks**

**Chuck Weitzel, Freescale**

• **Subgroup (5) : Millimeter Wave System (5)**

**Tony Immorlica, BAE Systems**



# Wireless Roadmap Highlights

- **CMOS**

- **Performance Analog CMOS**

- **Base on Logic Low STandby Power (LSTP) CMOS roadmap with 1 year lag (Supply Voltage,  $T_{ox}$ , Gate length )**
- **Added RF AMS parameters:  $G_m/G_{ds}$ ,  $1/f$  noise,  $V_t$  matching,  $F_t/F_{max}$ . Noise Fig**

- **Precision Analog CMOS**

- **Thick gate oxide CMOS**

- **Bipolar**

- **3 Separate Bipolar devices:**

- **RF – “typical” low-cost bipolar device for <10GHz wireless transceiver**
- **High Speed – mm-Wave applications**
- **High Voltage – power amplifier applications**



# Wireless Roadmap Highlights

- **On-Chip Passives**

- 3 applications: Analog, RF and Power Amplifier
- Devices include: Capacitors, Resistors, Inductors, Varactors

- **Power Amplifier**

- Handset and Base station
- Handset : HBT & FET, III-V and Si
- Base Station: Cellular and emerging WiMAX

Required relatively high RF power, LDMOS & III-V FET

- **mm-Wave**

- Dominates by III-V (GaAs MESFET, GaAs PHEMT, InP HEMT, GaAs MHEMT, GaN HEMT, InP HBT ), plus SiGe HBT
- Low noise amplifier and power devices



# 2006 Requirement Tables Updates

- **No major updates from 2005 Roadmap**
- **CMOS**
  - No wireless specific updates
- **Bipolar**
  - update the  $J_c$  at peak HF device  $F_t$  to reflect recent data
- **Passives**
  - clarify voltage and temperature for the capacitor leakages
- **mm-Wave**
  - InP HBT
  - GaN



# 2006 Updates for mm-wave

- **InP HBTs**

- Predictions on target and solutions in hand
  - $f_t/f_{\max}$  400/450 GHz demonstrated
- Addresses market needs in Digital Synthesizers, A/D converters, mixed signal

- **GaN HEMTs**

- Significant power density advantage over all other technologies
  - Record power densities at 40 GHz of 10W/mm with 40 Volts drain bias\*
- Challenges for commercialization for mm-wave
  - Stability, leakage current at shorter gate lengths, and reliability
  - Cost and maturity of substrates and fabrication processes
  - Thermal management
- Significant progress since 2005, but commercialization will lag predictions by several years. No volume markets to drive earlier results.

GaN Ref:

T. Palacios et al, High Power AlGaN/GaN HEMTs for Ka-Band Applications IEEE Elec Dev Lett, V26, No.11, Nov 2005

P. Schuh et al, 20W GaN HPAs for Next Generation X-Band T/R Modules, 2006 IEEE MTT-S Symposium, paper WE3B-06, June 2006



# GaN HFET for Base Station Power Amplifiers

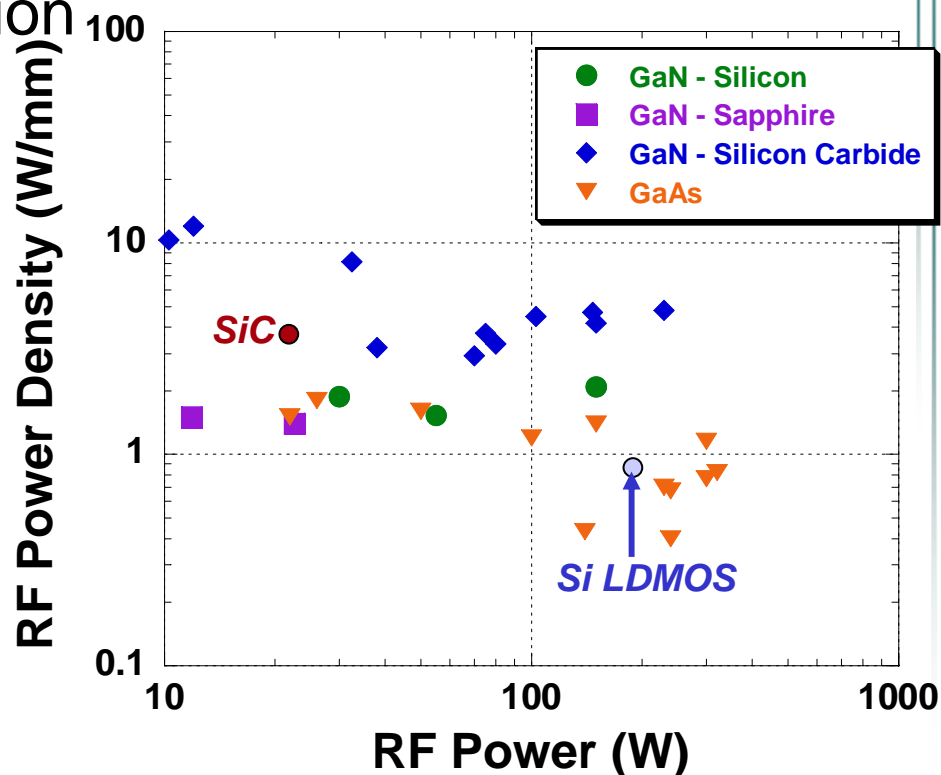
- GaN offers significantly higher RF power densities than GaAs
  - Lower loss matching, especially very large devices
  - Higher operating voltage, 48 V
  - Higher operating temperature possible
  - Optimize packaging to maximize advantage
  - Look for overall system advantage

- Challenges for commercialization

- Device DC and RF stability
- Device reliability
- Thermal management
- Cost Cost Cost

Power densities on SiC substrates 3-4 times those of best GaAs power FET's

GaN-GaAs Power > 10 W



# Cross-TWG Focus Software Defined Radio (SDR)

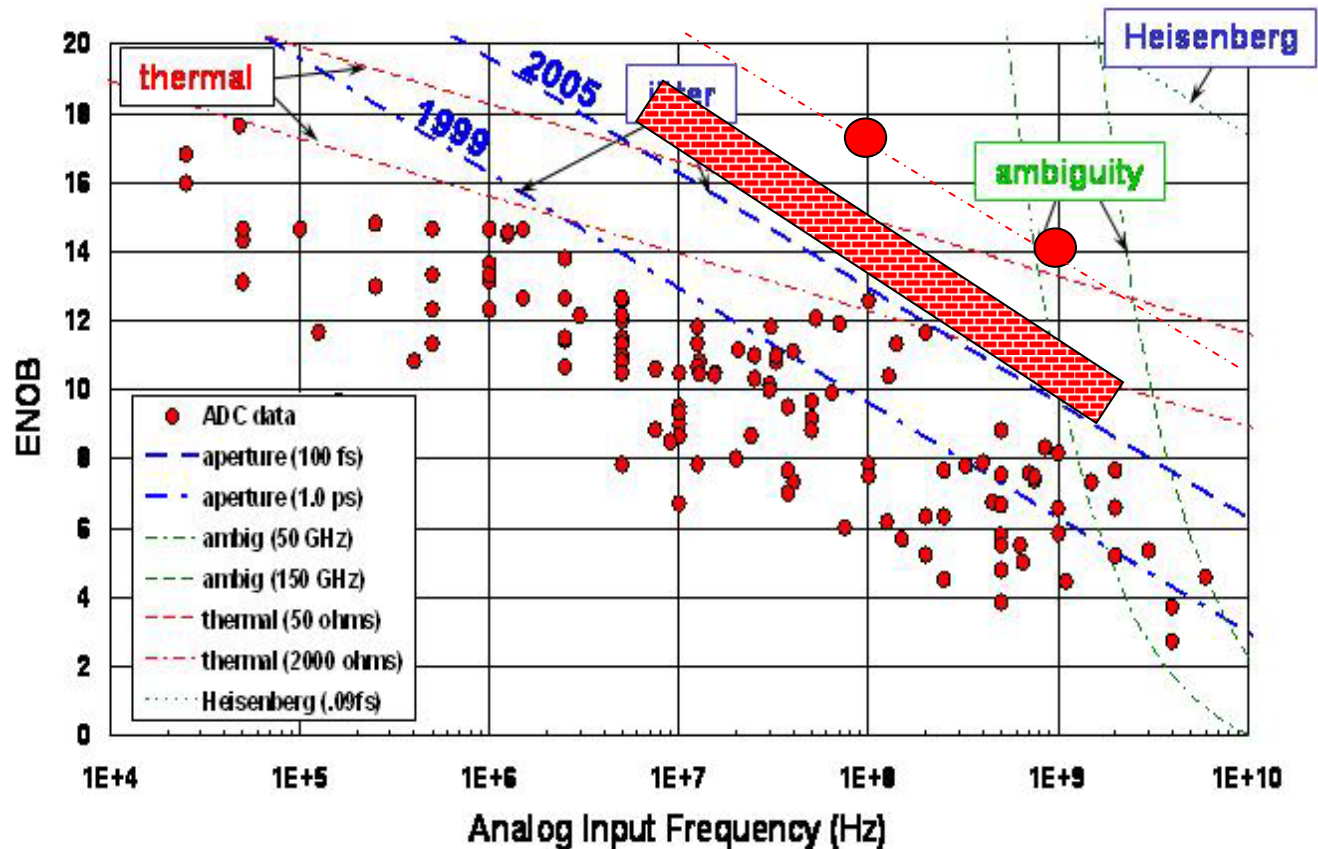
- Address multi-band, multi-mode, portable applications
- Digital radio:
  - ADC performance (sample rate, resolution, power consumption)
  - Transmit solution (power out, linearity & efficiency)
  - Cost (size, time-to-market)
- Hybrid with RF/Analog front end:
  - Wideband LNA
  - Multiple PAs + switch
  - Single PA with matching and switch network (linearity & efficiency)
- Present device roadmap alone does not enable SDR; needs to:
  - Address digital radio design requirements
  - Address module assembly and embedded passives requirements
  - Add filter and switch (MEMS) requirements for hybrid approach (2007)



# Analog-to-Digital Converter Technology

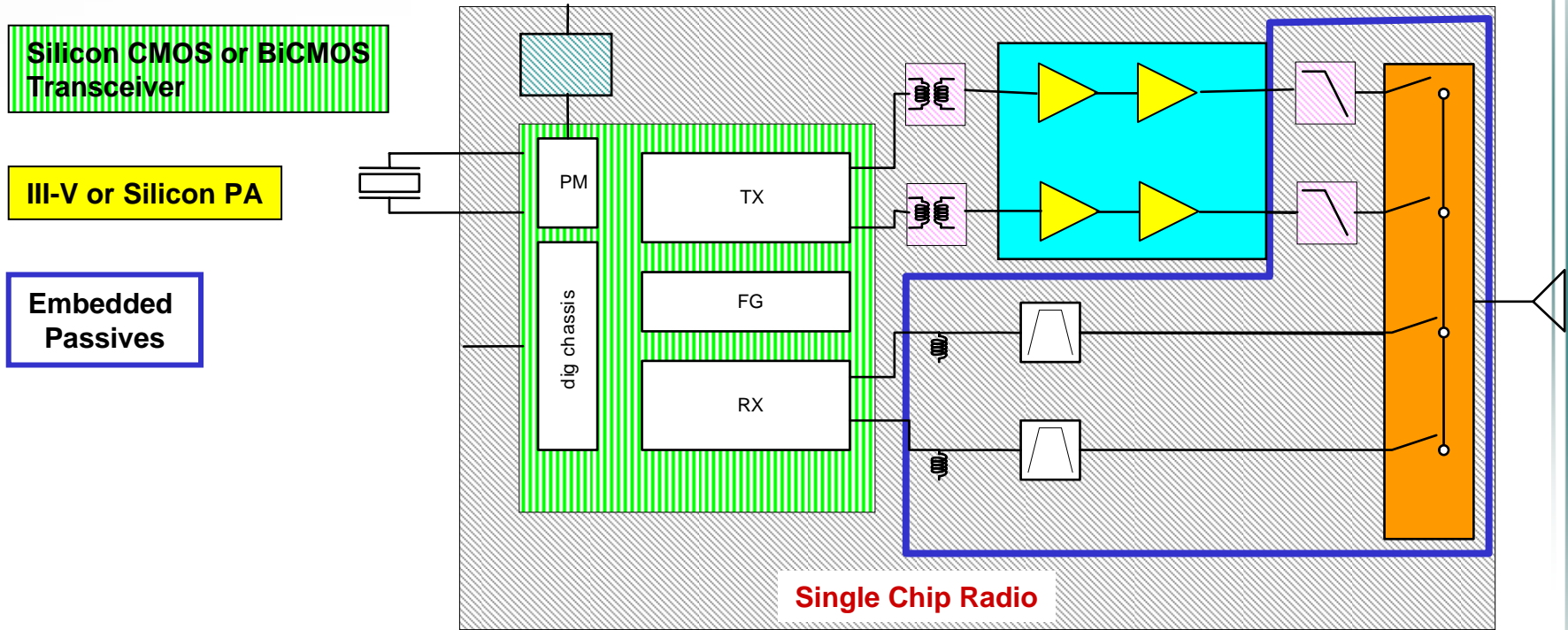
- Needed for all-digital receivers at reasonable power consumption

**ADC State-of-the-Art (December 2005)**  
every point represents one converter



- Drivers in Handset Application:
- IF Frequency  
⇒ Sample Rate
  - Dynamic Range  
⇒ Resolution
  - Power consumption

# SiP Module System Integration



Ref: W.M. Huang, RFIC Workshop 2005



# Cross-TWG Focus - Assy&Pkg

- **Wireless focus on functional requirement,**
- **Assy&Pkg focus on how to provide solution**
- **Initial focus on <10GHz Front End Module (PA, switch, filter drive)**
- **Assembly**
  - **Wireless to provide Front End Module /SiP Radio Assembly requirements**
    - e.g. Laminate Requirements: surface mount component, Die mounting technology, # routing layers, Design Rule Mismatch between Semi and Laminate (flip-chip bump size&pitch), thermal management (power density), cost
  - **Wireless to determine need for stacked Die for Radio Front End**
  - **Wireless to provide Switch & Filter assembly requirements**
- **Components and Embedded Components**
  - **Generic PA and on-chip passive spec (current Wireless tables)**
  - **Wireless to provide off-chip Passives requirements (Assy&Pkg table)**
    - T-Lines, Inductors, Caps, R's, Vias, Couplers/Detectors, Current&Voltage ratings under mismatch, tolerance, model (Design TWG?)
  - **Discussion for roadmap coverage:**
    - SMT, Passive Chips, Embedded Components (substrate)



# Wireless Working Group Key Considerations

## Traditional Roadmap Drivers:

- Cost (scaling, die size, part count)
- Power Consumption
- Chip Functionality

## Non-traditional Roadmap Drivers:

- Government regulations determining system spectrum and specifications
- Standards and protocols drive frequencies, power and performance
- Production Volume – specialty foundries and captive applications

## Cost / Performance Drives Integration:

- Multi-band Multi-mode system applications (SiP Functionality)
- RF modules, embedded passives, filter and T/R switch integration (MEMS)
- Signal Isolation
- Analog Shrink (power supply, area, design innovations)



# Challenges and Trends

## Radio Integration:

- Performance and cost trade off for SoC vs SiP solution
- Signal isolation - challenge to technologists, designers and EDA tool providers
- CAD solution for Integrated Radio SiP design (chip, passive, component, package, tool compatibility, model accuracies)

## Device Technology:

- Optimizing analog/RF CMOS devices with scaled technologies. Fundamental changes in CMOS device structure device may lead to the need of separate process/chip to support conventional precision analog/RF devices
- Cost and performance tradeoff of integrating passive devices
- Predictability of battery technology and its impact on PA roadmap
- Compound semiconductor substrate quality, reliability, new thermal management

## Design:

- Design approach for PA ruggedness
- Digitizing analog functions, Software Define Radio (SDR)



# Publications

- H. S. Bennett, R. Brederlow, J. Costa, P. Cottrell, W. M. Huang, A. A. Immorlica Jr., J-E Mueller, M. Racanelli, H. Shichijo, C. E. Weitzel, B. Zhao, “Radio-Frequency and Analog Mixed-Signal Circuits and Devices for Wireless Communications”, IEEE Circuits and Devices Magazine, Nov. 2004, pp. 38-51.
- H. S. Bennett, R. Brederlow, J. Costa, P. Cottrell, W. M. Huang, A. A. Immorlica Jr., J-E Mueller, M. Racanelli, H. Shichijo, C. E. Weitzel, B. Zhao, “The Compound Semiconductor Roadmap Embedded in the ITRS: Implications for the MANTECH Community”, Mantech, April 2005, New Orleans.
- C. E. Weitzel, “Will GaAs Survive Wireless PAs?,” Mantech, April 2005, New Orleans.
- H. S. Bennett, J. Costa, A. A. Immorlica Jr., and C.E. Weitzel, “Opportunities And Challenges For Indium Phosphide And Related Materials: International Technology Roadmap For Semiconductors Perspective,” International Conference on InP and Related Materials (IPRM), May 2005, Glasgow.
- H. S. Bennett, R. Brederlow, J. Costa, P. Cottrell, W. M. Huang, A. A. Immorlica Jr., J-E Mueller, M. Racanelli, H. Shichijo, C. E. Weitzel, B. Zhao, “Device and Technology Evolution for Si-Based RF Integrated Circuits”, IEEE Trans. On Electron Dev., July 2005, pp. 1235-1258.
- S. Decoutere, W. M. Huang, H. S. Bennett, J. Costa, P. Cottrell, A. A. Immorlica Jr., J-E Mueller, M. Racanelli, H. Shichijo, C. E. Weitzel, B. Zhao, “Process Issues and ITRS Relationship”, SEMI Europe Standards Autumn Conference - Standard Electronics Manufacturing Initiatives for Wireless Communication Devices, Oct. 2005, Leuven.



# Published Cont'd

- J-E Mueller, "ITRS Roadmap for Wireless Technologies", GMM Workshop Germany 2006
- W. M. Huang, H. S. Bennett, J. Costa, P. Cottrell, A. A. Immorlica Jr., J-E Mueller, M. Racanelli, H. Shichijo, C. E. Weitzel, B. Zhao, "RF, Analog and Mixed Signal Technologies for Communication ICs - An ITRS Perspective", BCTM 2006.
- B. Zhao, H. S. Bennett, J. Costa, P. Cottrell, W. M. Huang, A. A. Immorlica Jr., J-E Mueller, M. Racanelli, H. Shichijo, and C. E. Weitzel, "Future Perspective of Analog/Mixed-Signal and RF Integrated Circuit Technologies", ICSICT 2006.

